## Search Notes



Application/Control No.

10516750

Reexamination

ARAI ET AL.

Applicant(s)/Patent Under

Examiner

Jaisle, Cecilia M

**Art Unit** 

1624

SEARCHED							
Class		Subclass	Date	Examiner			
544	279		12/18/2006	Cocilia Inicio			

SEARCH NOTES							
Search Notes	Date	Examiner					
STN search by STIC	12/18/2006	Cecilia Jaisle					

INTERFERENCE SEARCH							
Class	Subclass	Date	Examiner				
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